

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10590850	FUJISAWA ET AL.
	Examiner	Art Unit
	Cho, Jennifer Y	1621

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
STIC Search	11/19/07	LH
East Search	11/19/07	JC
Inventor Search	11/19/07	JC
Updated East Search	6/6/08	JC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner